



## Inductance Analyzers - 3255B and 3255BQ

- Frequency ranges from 20 Hz to 1 MHz
- Fast measurement speed - up to 20 measurements per second
- 0.1% basic accuracy
- Up to 125 A of DC bias current
- Comprehensive measurement functions
- Straightforward intuitive operation
- Print test results
- GPIB control with LabVIEW™ driver

### Completely characterize components with comprehensive parametric tests

3255B and 3255BQ are highly versatile and accurate inductance analyzers able to characterise devices in a clear and simple manner. 3255B covers to 500 kHz and 3255BQ covers to 1 MHz.

At the design stage of component development it is very important to analyse how components performs under different operating conditions. This includes operation over a range of frequencies, AC drive levels or DC bias currents.

The AC drive level can be set between 1 mV to 10 V. DC bias current can be set from 1 mA to 1 A internally (optional). Using the external 3265B 25 A DC Bias Units bias currents can be set to a maximum of 125 A.

### Specification summary

Measurement functions	Z, $\emptyset$ , L, C, Rac, Rdc, Q, D, turns ratio
Frequency ranges	20 Hz to 500 kHz (3255B) 20 Hz to 1 MHz (3255BQ)
Basic accuracy	0.1%
Modes	Impedance Multi frequency Bin handler (optional)
DC bias current	1 mA to 1 A - internal (optional) Up to 125 A (using five 3265B DC Bias Units)
Interface	GPIB (option)
Measurement speed	Up to 20 measurements/sec

### Printed output of test results

Using the parallel Centronics interface the user can directly print all test results for further analysis and archiving.

In addition, via the optional GPIB interface, the instrument can be controlled from a PC and results can be read back for analysis and storage.

LabVIEW™ drivers are available on request or can be downloaded from the web site, [www.waynekerrtest.com](http://www.waynekerrtest.com), providing a base from which a user can develop a specific test application.

## Bin sort

The binning function allows component manufacturers to sort components in up to ten bins. Sorting is carried out either by absolute values or by percentage of values.

## Component tests with up to 125 A DC bias current

To evaluate components at high currents of up to 125 A the optional 3265B DC Bias Unit is used.

With one 3265A DC unit a bias current of up to 25 A can be set in steps of 0.025 A.

Up to five of the DC Bias Units can be used in parallel to give a wide range of DC bias currents up to a maximum of 125 A.

The 3255B Inductance Analyzer can optionally provide an internal DC bias from 1 mA to 1 A.

The 3265B has a number of safety and protection features including a safety interlock system to protect users against back EMFs. It is also fully protected against over temperature, excess voltage drop and sense lead failure.



*3265B DC Bias Unit can deliver up to 25 A of DC bias current in steps of 0.025 A*

## SMD inductor tests up to 50 A

With the addition of the 1009 DC Bias Fixture DC bias currents up to 50 A can be applied to an SMD inductor during component test in order to evaluate the devices thoroughly at the operational bias currents.

The fixture operates with either one or two 3265B DC bias units and a 3255B Inductance Analyzer.

Four rear panel mounted BNC connectors and two captive high current cables ensure simplicity and ease of use with the 3265B.

Interchangeable component test carriers ensure that the 1009 DC Bias Fixture may be used with a wide variety of devices. If a device package is not supported by one of the standard carriers then a custom carrier design service is available.

Stable component fixturing ensures high accuracy and repeatable measurements. Enclosed fixtures, with safety interlocks, minimises risk to operators.



*1009 DC Bias Fixture enables currents up to 50 A to be applied to an SMD inductor*

## Technical specifications Inductance Analyzer - 3255B

### Operation modes

#### **Impedance mode**

Inductance (L), Impedance (Z), DC Resistance (Rdc) and Capacitance (C).  
Series or parallel equivalent circuit  
Loss term: Quality factor (Q), Dissipation factor (D), AC Resistance (Rac) and Phase Angle ( $\emptyset$ ) Turns Ratio  
Percentage difference mode and relative mode on major terms.

#### **Multi-frequency mode**

Measurement parameters and test conditions set using measurement mode. Up to eight frequencies with absolute or percentage limits on major term with PASS/FAIL indications.

### Test conditions

#### **Low level AC drive**

For measurement of L + Q, Ls + Rs, C, Z, Turns Ratio

#### **Frequency ranges**

20 Hz to 500 kHz (3255B)  
20 Hz to 1 MHz (3255BQ)

#### **Steps**

At least 800 frequency steps are available which may be selected via the keypad or GPIB.  
Basic accuracy of selected frequency  $\pm 0.01\%$

#### **Drive level**

Source impedance 50  $\Omega$   
1 mV to 10 V rms into open circuit  
50  $\mu$ A to 200 mA rms into short circuit  
Automatic Level Control (ALC) maintains level applied to Device Under Test (DUT) at  $\pm 2\%$ ,  $\pm 1$  mV of set voltage or  $\pm 2\% \pm 0.1$  mA of set current, reduces to  $\pm 4\%$  below 100 Hz.

#### **DC bias current (option)**

1mA to 1A DC is available from internal, fast settling bias supply over full frequency range.  
Voltage compliance 14 V minimum  
DC Accuracy 2%  $\pm 0.25$  mA  
Enabling DC bias inherently reduces measurement accuracy.  
Safety interlock minimises operator exposure to high currents.

#### **DC resistance**

Low test level of 100 mV minimises heating of the DUT  
Short circuit current 10 mA.

#### **Bin handler mode (option)**

Sort to 1 of 10 bins using absolute or percentage limits.  
Separate Pass/Fail output.  
Up to 100 bin limit set-ups stored in non-volatile memory.  
TTL interface to external bin handler via 25 way D type connector.

### Measurement speeds

For Impedance, Turns Ratio, DC Resistance  
4 speeds selectable for all functions: MAXimum, FAST, MEDium and SLOW

Maximum for remote control. Up to 20 measurements per second for test frequency  $\geq 100$  Hz. Selecting slower speeds improves accuracy and display resolution.

### Measurement ranges

R 0.05 m $\Omega$  to  $>2$  M $\Omega$   
L 1 nH to  $>1000$  H  
C 0.01 pF to  $>250$  mF  
Rdc 0.5 m $\Omega$  to 50 k $\Omega$   
Turns Ratio 100:1 to 1:100

### Accuracy

L/C/Z/Turns Ratio  $\pm 0.1\%$   
Q  $\pm 0.1\%$  (Q+1/Q)  
D  $\pm 0.001$  (1+D2)  
Rdc  $\pm 0.5\% \pm 1$  m $\Omega$   
Note: Ranges and accuracy vary with measurement speed, frequency and options chosen

### General data

#### **Input specification**

Power supply  
230 V AC  $\pm 10\%$  or  
115 V AC  $\pm 10\%$  (selectable)  
50 to 400 Hz  
150 VA maximum consumption

#### **Display**

High contrast monochrome LCD  
320 x 240 dot with back lighting.  
Visible area 115 x 86mm.  
Viewing angle 45°

#### **Measurement connections**

4 front panel BNC sockets  
4-wire (Kelvin) measurements with screen at ground potential  
Equivalent circuit symbols on screen

#### **Remote control (option)**

Conforms with GPIB IEEE-488.2 and SCPI 1992.0

#### **Printer output**

Centronics/parallel printer port

## Environmental conditions

Temperature range  
Storage -40°C to 70°C  
Operating 0°C to 40°C  
Full Accuracy 15°C to 35°C

Altitude up to 2000m  
Relative humidity: up to 80% non-condensing  
Installation category: II (in accordance with IEC664)  
Pollution degree: 2 (mainly nonconductive)  
This equipment is intended for indoor use only in non-explosive, non-corrosive atmosphere.

## Safety

Complies with the requirements of EN61010-1

## EMC

Complies with EN50081-1, EN50082-1 generic emissions and immunity standards by meeting with the requirements of EN55022, IEC801.2, IEC801.3 and IEC801.4

## Mechanical (approx. overall)

Height 150 mm (6")  
Width 440 mm (17 <sup>3</sup>/<sub>8</sub>"")  
Depth 520 mm (20 <sup>1</sup>/<sub>2</sub>"")  
Weight 11 kg (24 lb 4 oz)

## Order codes and options

<i>Description</i>	<i>Order code</i>
3255B Inductance Analyzer – 500 kHz Supplied with user manual and power cable	<b>1J3255B</b>
3255BQ Inductance Analyzer - 1 MHz Supplied with user manual and power cable	<b>1J3255BQ</b>

## Options

/A 1 mA to 1 A internal DC bias  
/B GPIB (IEEE-488) interface  
/D Bin handler

## Auxiliary unit

25A DC bias unit 3265B **1J3265B**  
Supplied with user manual, power cable,  
spare fuses, 4 x BNC to BNC links, daisy chain  
link and rack mounting ears (unit needs rear support)

## Accessories

<i>Description</i>	<i>Order code</i>
1009 DC Bias Fixture	<b>1J1009</b>
Rack mounting kit, 3U x full width	<b>1EXA20230</b>
Kelvin clips (fine jaws).	<b>1EVA40100</b>
Kelvin clips (large jaws)	<b>1EVA40180</b>
4-terminal lead set	<b>1EV1505</b>
SMD Tweezers	<b>1EVA40120</b>
Bus bars	<b>4-324-6009</b>

## UK

Wayne Kerr Electronics  
Vinnetrow Business Park  
Vinnetrow Road, Runcton  
Chichester, West Sussex  
PO20 1QH, UK  
Tel: +44 1243 792200  
Fax: +44 1243 792201

## USA

Wayne Kerr Electronics  
165L New Boston Street  
Woburn  
MA 01801-6201 USA  
Tel: +1 781 938 8390  
Sales: (800) 933 9319  
Fax: +1 781 933 9523